| Effect                            | Uncertainty |
|-----------------------------------|-------------|
| Simulated sample size             | 2.4%        |
| Tracking efficiency correction    | 3.0%        |
| Fit quality efficiency correction | 1.5%        |
| Soft pion $p_{\rm T}$ cut         | 1.4%        |
| $\Xi_b^{*0}$ yield                | 1.0%        |
| $\Xi_b^-$ yield                   | 2.0%        |
| Sum in quadrature                 | 4.9%        |